# International Rectifier

# Strong/RFET™ IRFB7437PbF

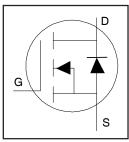
# **Applications**

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

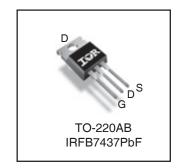
# **Benefits**

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free
- RoHS Compliant, Halogen-Free\*

# **HEXFET® Power MOSFET**



| V <sub>DSS</sub>                 | 40V                   |
|----------------------------------|-----------------------|
| R <sub>DS(on)</sub> typ.         | 1.5m $\Omega$         |
| max.                             | $\mathbf{2.0m}\Omega$ |
| I <sub>D (Silicon Limited)</sub> | 250A①                 |
| I <sub>D (Package Limited)</sub> | 195A                  |



| G    | D     | S      |
|------|-------|--------|
| Gate | Drain | Source |

| Base Part Number | Package Type | Standard Pa | ack      | Orderable Part Number |
|------------------|--------------|-------------|----------|-----------------------|
| base Part Number | rackage Type | Form        | Quantity | Orderable Part Number |
| IRFB7437PbF      | TO-220       | Tube        | 50       | IRFB7437PbF           |

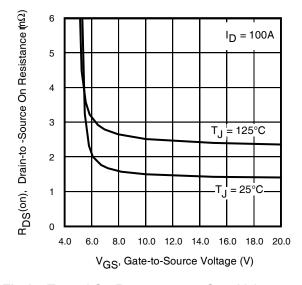


Fig 1. Typical On-Resistance vs. Gate Voltage

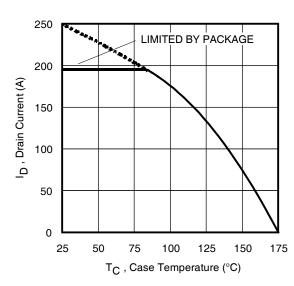


Fig 2. Maximum Drain Current vs. Case Temperature



**Absolute Maximum Ratings** 

| Symbol                                  | Parameter                                                           | Max.                | Units |
|-----------------------------------------|---------------------------------------------------------------------|---------------------|-------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)   | 250①                |       |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)   | 180                 | ^     |
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V (Wire Bond Limited) | 195                 | A     |
| I <sub>DM</sub>                         | Pulsed Drain Current ②                                              | 1000                |       |
| P <sub>D</sub> @T <sub>C</sub> = 25°C   | Maximum Power Dissipation                                           | 230                 | W     |
|                                         | Linear Derating Factor                                              | 1.5                 | W/°C  |
| $V_{GS}$                                | Gate-to-Source Voltage                                              | ± 20                | V     |
| T <sub>J</sub>                          | Operating Junction and                                              | -55 to + 175        |       |
| T <sub>STG</sub>                        | Storage Temperature Range                                           |                     | °C    |
|                                         | Soldering Temperature, for 10 seconds (1.6mm from case)             | 300                 |       |
|                                         | Mounting torque, 6-32 or M3 screw                                   | 10lbf· in (1.1N· m) |       |

# **Avalanche Characteristics**

| E <sub>AS (Thermally limited)</sub> | Single Pulse Avalanche Energy ③ | 350                       | mJ |
|-------------------------------------|---------------------------------|---------------------------|----|
| E <sub>AS (Thermally limited)</sub> | Single Pulse Avalanche Energy ® | 802                       |    |
| I <sub>AR</sub> Avalanche Current ② |                                 | See Fig. 14, 15, 22a, 22b | А  |
| E <sub>AR</sub>                     | Repetitive Avalanche Energy ②   |                           | mJ |

# **Thermal Resistance**

| Symbol           | Parameter                          | Тур. | Max. | Units |
|------------------|------------------------------------|------|------|-------|
| $R_{\Theta C}$   | Junction-to-Case ®                 |      | 0.65 |       |
| R <sub>ecs</sub> | Case-to-Sink, Flat Greased Surface | 0.50 |      | °C/W  |
| R <sub>eJA</sub> | Junction-to-Ambient ®              |      | 62   |       |

# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

| Symbol                            | Parameter                            | Min. | Тур.  | Max. | Units | Conditions                                           |
|-----------------------------------|--------------------------------------|------|-------|------|-------|------------------------------------------------------|
| V <sub>(BR)DSS</sub>              | Drain-to-Source Breakdown Voltage    | 40   |       |      | V     | $V_{GS} = 0V, I_D = 250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_{J}$ | Breakdown Voltage Temp. Coefficient  |      | 0.029 |      | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA <sup>②</sup> |
| R <sub>DS(on)</sub>               | Static Drain-to-Source On-Resistance |      | 1.5   | 2.0  | mΩ    | $V_{GS} = 10V, I_D = 100A$                           |
|                                   |                                      |      | 1.8   |      |       | $V_{GS} = 6.0V, I_D = 50A$                           |
| V <sub>GS(th)</sub>               | Gate Threshold Voltage               | 2.2  | 3.0   | 3.9  | V     | $V_{DS} = V_{GS}$ , $I_D = 150\mu A$                 |
| I <sub>DSS</sub>                  | Drain-to-Source Leakage Current      |      |       | 1.0  | μΑ    | $V_{DS} = 40V$ , $V_{GS} = 0V$                       |
|                                   |                                      |      |       | 150  |       | $V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$    |
| I <sub>GSS</sub>                  | Gate-to-Source Forward Leakage       |      |       | 100  | nA    | V <sub>GS</sub> = 20V                                |
|                                   | Gate-to-Source Reverse Leakage       |      |       | -100 |       | V <sub>GS</sub> = -20V                               |
| R <sub>G</sub>                    | Internal Gate Resistance             |      | 2.2   |      | Ω     |                                                      |

#### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\label{eq:limited} \begin{tabular}{ll} \hline \& Limited by $T_{Jmax}$, starting $T_{J}=25^{\circ}C$, $L=0.069mH$\\ $R_{G}=50\Omega$, $I_{AS}=100A$, $V_{GS}=10V$. \end{tabular}$
- ④  $I_{SD} \le 100A$ , di/dt ≤ 1166A/µs,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_{J} \le 175$ °C.

- ⑤ Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- $^{\circ}$  C<sub>oss</sub> eff. (TR) is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- $\odot$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- $\ \, \ \, \ \,$  Limited by T\_J\_max starting T\_J = 25°C, L= 1mH, R\_G = 50  $\Omega$ , I\_AS = 40A, V\_GS =10V.
- \* Halogen -Free since April 30, 2014



# Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

| Symbol                     | Parameter                                                   | Min. | Тур. | Max. | Units | Conditions                                                   |
|----------------------------|-------------------------------------------------------------|------|------|------|-------|--------------------------------------------------------------|
| gfs                        | Forward Transconductance                                    | 160  |      |      | S     | $V_{DS} = 10V, I_{D} = 100A$                                 |
| $Q_g$                      | Total Gate Charge                                           |      | 150  | 225  | nC    | I <sub>D</sub> = 100A                                        |
| $Q_{gs}$                   | Gate-to-Source Charge                                       |      | 41   |      | ľ     | V <sub>DS</sub> =20V                                         |
| $Q_{gd}$                   | Gate-to-Drain ("Miller") Charge                             |      | 51   |      | ľ     | V <sub>GS</sub> = 10V ⑤                                      |
| Q <sub>sync</sub>          | Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> ) |      | 99   |      |       | $I_D = 100A, V_{DS} = 20V, V_{GS} = 10V$                     |
| t <sub>d(on)</sub>         | Turn-On Delay Time                                          |      | 19   |      | ns    | $V_{DD} = 20V$                                               |
| t <sub>r</sub>             | Rise Time                                                   |      | 70   |      |       | $I_D = 30A$                                                  |
| $t_{d(off)}$               | Turn-Off Delay Time                                         |      | 78   |      | ľ     | $R_G = 2.7\Omega$                                            |
| t <sub>f</sub>             | Fall Time                                                   |      | 53   |      | ľ     | V <sub>GS</sub> = 10V ⑤                                      |
| C <sub>iss</sub>           | Input Capacitance                                           |      | 7330 |      | pF    | $V_{GS} = 0V$                                                |
| C <sub>oss</sub>           | Output Capacitance                                          |      | 1095 |      |       | $V_{DS} = 25V$                                               |
| C <sub>rss</sub>           | Reverse Transfer Capacitance                                |      | 745  |      | ľ     | f = 1.0 MHz, See Fig. 5                                      |
| C <sub>oss</sub> eff. (ER) | Effective Output Capacitance (Energy Related) ⑦             |      | 1310 |      |       | $V_{GS} = 0V$ , $V_{DS} = 0V$ to 32V $\bigcirc$ , See Fig. 1 |
| C <sub>oss</sub> eff. (TR) | Effective Output Capacitance (Time Related)®                |      | 1735 |      |       | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V  $                 |

# **Diode Characteristics**

| Symbol           | Parameter                 | Min. | Тур. | Max. | Units | Conditions                                        |
|------------------|---------------------------|------|------|------|-------|---------------------------------------------------|
| Is               | Continuous Source Current |      |      | 250① | Α     | MOSFET symbol                                     |
|                  | (Body Diode)              |      |      |      |       | showing the                                       |
| I <sub>SM</sub>  | Pulsed Source Current     |      |      | 1000 | Α     | integral reverse                                  |
|                  | (Body Diode) ②            |      |      |      |       | p-n junction diode.                               |
| $V_{SD}$         | Diode Forward Voltage     |      | 1.0  | 1.3  | ٧     | $T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V$ §    |
| dv/dt            | Peak Diode Recovery ®     |      | 3.1  |      | V/ns  | $T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 40V $   |
| t <sub>rr</sub>  | Reverse Recovery Time     |      | 30   |      | ns    | $T_J = 25^{\circ}C$ $V_R = 34V$ ,                 |
|                  |                           |      | 30   |      |       | $T_J = 125^{\circ}C$ $I_F = 100A$                 |
| Q <sub>rr</sub>  | Reverse Recovery Charge   |      | 24   |      | nC    | $T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\odot$ |
|                  |                           |      | 25   |      |       | $T_J = 125$ °C                                    |
| I <sub>RRM</sub> | Reverse Recovery Current  |      | 1.3  |      | Α     | $T_J = 25^{\circ}C$                               |



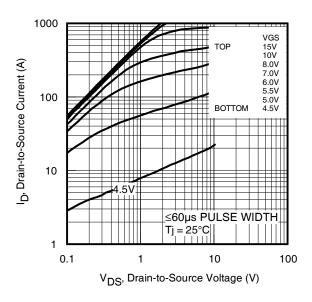


Fig 3. Typical Output Characteristics

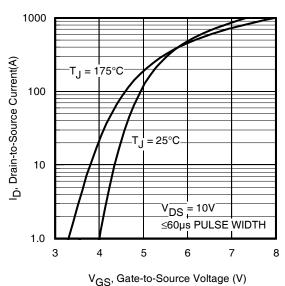


Fig 5. Typical Transfer Characteristics

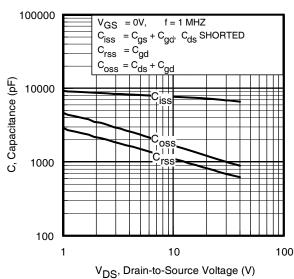


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

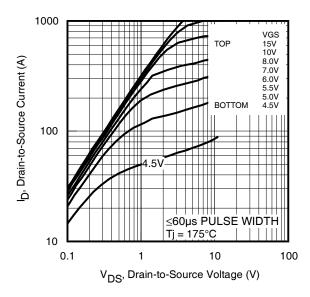


Fig 4. Typical Output Characteristics

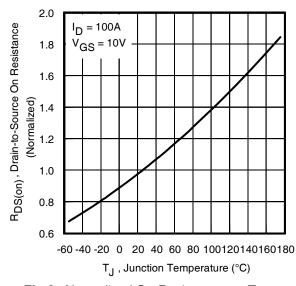


Fig 6. Normalized On-Resistance vs. Temperature

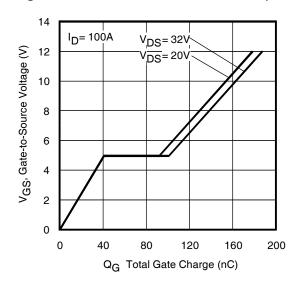
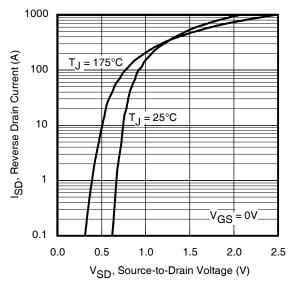


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage





**Fig 9.** Typical Source-Drain Diode Forward Voltage

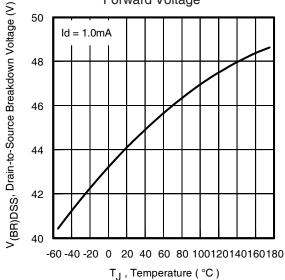


Fig 11. Drain-to-Source Breakdown Voltage

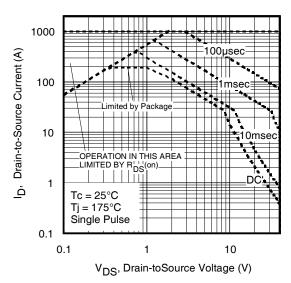


Fig 10. Maximum Safe Operating Area

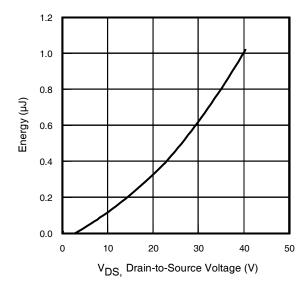


Fig 12. Typical C<sub>OSS</sub> Stored Energy

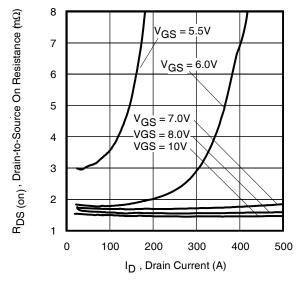


Fig 13. Typical On-Resistance vs. Drain Current



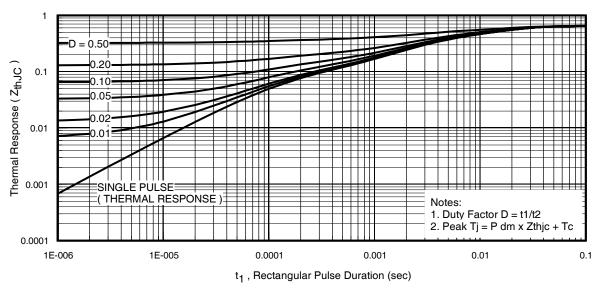


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

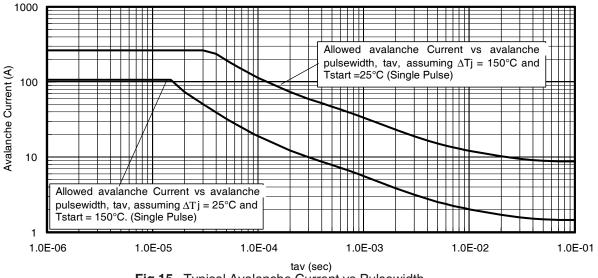


Fig 15. Typical Avalanche Current vs. Pulsewidth

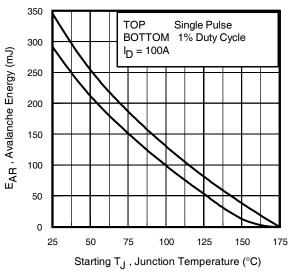


Fig 16. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>imax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

 $t_{av}$  = Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,IC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D~(ave)} &= 1/2~(~1.3\text{-BV}\cdot I_{av}) = \triangle T/~Z_{thJC}\\ I_{av} &= 2\triangle T/~[1.3\text{-BV}\cdot Z_{th}]\\ E_{AS~(AR)} &= P_{D~(ave)}\cdot t_{av} \end{split}$$

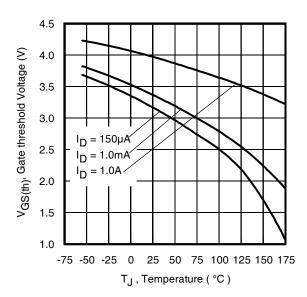


Fig 17. Threshold Voltage vs. Temperature

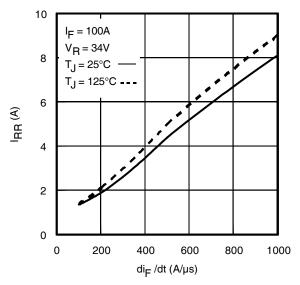


Fig. 19 - Typical Recovery Current vs. dif/dt

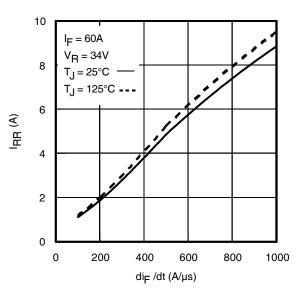


Fig. 18 - Typical Recovery Current vs. dif/dt

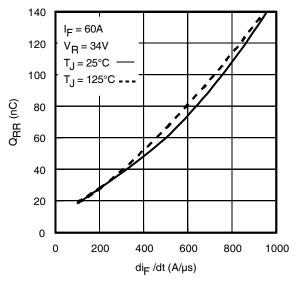


Fig. 20 - Typical Stored Charge vs. dif/dt

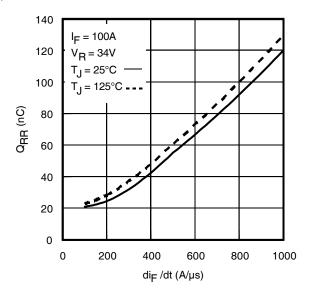


Fig. 21 - Typical Stored Charge vs. dif/dt



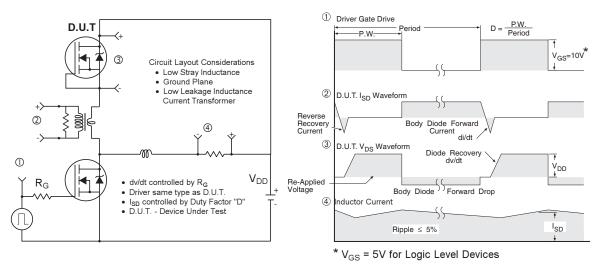


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

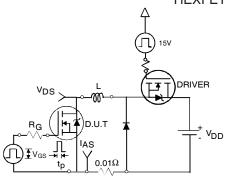


Fig 23a. Unclamped Inductive Test Circuit

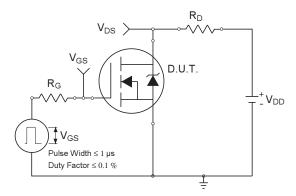


Fig 24a. Switching Time Test Circuit

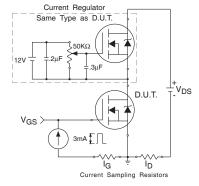


Fig 25a. Gate Charge Test Circuit

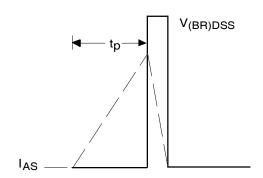


Fig 23b. Unclamped Inductive Waveforms

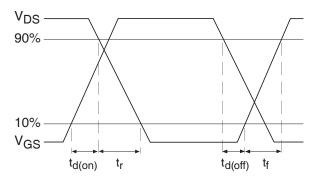


Fig 24b. Switching Time Waveforms

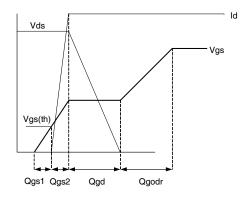
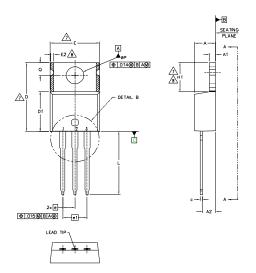


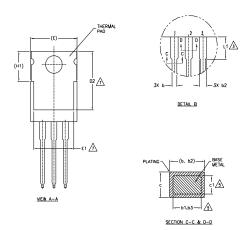
Fig 25b. Gate Charge Waveform



# TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





#### NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2.-DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (mox.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

|        | DIMENSIONS   |       |              |      |       |
|--------|--------------|-------|--------------|------|-------|
| SYMBOL | MILLIM       | ETERS | INC          | HES  |       |
|        | MIN.         | MAX.  | MIN.         | MAX. | NOTES |
| Α      | 3.56         | 4,83  | .140         | ,190 |       |
| A1     | 1.14         | 1.40  | .045         | .055 |       |
| A2     | 2.03         | 2.92  | .080         | .115 |       |
| b      | 0.38         | 1.01  | .015         | .040 |       |
| b1     | 0.38         | 0.97  | .015         | .038 | 5     |
| b2     | 1.14         | 1.78  | .045         | .070 |       |
| b3     | 1,14         | 1.73  | .045         | .068 | 5     |
| С      | 0.36         | 0.61  | .014         | .024 |       |
| c1     | 0.36         | 0.56  | .014         | .022 | 5     |
| D      | 14.22        | 16.51 | .560         | .650 | 4     |
| D1     | 8.38         | 9.02  | .330         | .355 |       |
| D2     | 11.68        | 12.88 | .460         | .507 | 7     |
| E      | 9.65         | 10.67 | .380         | .420 | 4,7   |
| E1     | 6.86         | 8.89  | .270         | .350 | 7     |
| E2     | _            | 0.76  | -            | .030 | 8     |
| e      | 2.54<br>5.08 | BSC   | .100<br>.200 | BSC  |       |
| e1     | 5.08         | BSC   | .200         | BSC  |       |
| H1     | 5.84         | 6.86  | .230         | .270 | 7,8   |
| L      | 12.70        | 14,73 | .500         | .580 |       |
| L1     | 3.56         | 4,06  | .140         | .160 | 3     |
| øΡ     | 3.54         | 4.08  | .139         | .161 |       |
| Q      | 2.54         | 3.42  | .100         | .135 |       |

### LEAD ASSIGNMENTS

#### HEXFET

1.- GATE 2.- DRAIN

3.- SOURCE

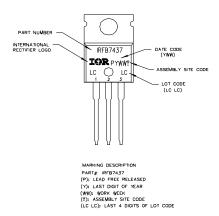
#### IGBTs, CoPACK 1 - GATE

2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

# TO-220AB Part Marking Information



TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/



# Qualification information+

| Qualification level        | Industrial                                   |  |  |  |  |
|----------------------------|----------------------------------------------|--|--|--|--|
|                            | (per JEDEC JESD47F <sup>††</sup> guidelines) |  |  |  |  |
| Moisture Sensitivity Level | TO-220 Not applicable                        |  |  |  |  |
| RoHS compliant             | Yes                                          |  |  |  |  |

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <a href="http://www.irf.com/product-info/reliability/">http://www.irf.com/product-info/reliability/</a>

# **Revision History**

| Date      | Comment                                                                                                                                                                 |
|-----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|           | Updated data sheet with new IR corporate template.                                                                                                                      |
| 4/22/2014 | • Updated typo on the fig.19 and fig.21, unit of y-axis from "A" to "nC" on page7.                                                                                      |
| 4/22/2014 | Updated package outline and part marking on page 9.                                                                                                                     |
|           | • Added bullet point in the Benefits "RoHS Compliant, Halogen -Free" on page 1.                                                                                         |
| 1/6/2015  | ● Updated E <sub>AS (L=1mH)</sub> = 802mJ on page 2                                                                                                                     |
| 1/0/2015  | • Updated note 9 "Limited by T <sub>Jmax</sub> , starting T <sub>J</sub> = 25°C, L = 1mH, R <sub>G</sub> = 50Ω, I <sub>AS</sub> = 40A, V <sub>GS</sub> =10V". on page 2 |



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<sup>††</sup> Applicable version of JEDEC standard at the time of product release.

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